

Notice of References Cited	Application/Control No. 09/013,819	Applicant(s)/Patent Under Reexamination OUDERKIRK ET AL.	
	Examiner Ricky D. Shafer	Art Unit 2872	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-4,268,840	05-1981	Schank et al.	346/135.1
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NON-PATENT DOCUMENTS

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	U	R. Guenther, "Modern Optics", John Wiley & Sons, New York, 1990, pp. 523 to 525 and pp. 533 to 534.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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